

Author index for papers in Volume 45

Pages are numbered consecutively through the volume: 1–184, January; 185–360, March; 361–600, May/July; 601–760, September; 761–870, November.

Abali, B., H. Franke, D. E. Poff, R. A. Saccone, Jr., C. O. Schulz, L. M. Herger, and T. B. Smith
287 *Memory Expansion Technology (MXT): Software support and performance*

Abali, B.
303 see Smith, T. B.

Agrafiotis, D. K.
545 *Multiobjective optimization of combinatorial libraries*

Alfonseca, M., and A. Ortega
797 *Determination of fractal dimensions from equivalent L systems*

Alvarado, S. F., L. Rossi, P. Müller, P. F. Seidler, and W. Riess
89 *STM-excited electroluminescence and spectroscopy on organic materials for display applications*

Andreoni, W., A. Curioni, and T. Mordasini
397 *DFT-based molecular dynamics as a new tool for computational biology: First applications and perspective*

Andreoni, W.
101 see Curioni, A.

Angelopoulos, M.
57 *Conducting polymers in microelectronics*

Angelopoulos, M.
639 see Medeiros, D. R.

Aviram, A.
639 see Medeiros, D. R.

Ayton, G. S. D., S. Bardenhagen, P. McMurtry, D. Sulsky, and G. A. Voth
417 *Interfacing molecular dynamics with continuum dynamics in computer simulation: Toward an application to biological membranes*

Baker, N. A., D. Sept, M. J. Holst, and J. A. McCammon
427 *The adaptive multilevel finite element solution of the Poisson–Boltzmann equation on massively parallel computers*

Bardenhagen, S.
417 see Ayton, G. S. D.

Basch, H.
367 see Morokuma, K.

Bates, A. K., M. Rothschild, T. M. Bloomstein, T. H. Fedynyshyn, R. R. Kunz, V. Liberman, and M. Switkes
605 *Review of technology for 157-nm lithography*

Beierlein, T.
77 see Riess, W.

Bernard, A.
697 see Michel, B.

Betley, T. A.
47 see Murray, C. B.

Bietsch, A.
697 see Michel, B.

Birney, E.
449 *Hidden Markov models in biological sequence analysis*

Bland, P. M.
271 see Tremaine, R. B.

Bloomstein, T. M.
605 see Bates, A. K.

Brock, B. C., G. D. Carpenter, E. Chiprout, M. E. Dean, P. L. De Backer, E. N. Elnozahy, H. Franke, M. E. Giampapa, D. Glasco, J. L. Peterson, R. Rajamony, R. Ravindran, F. L. Rawson, R. L. Rockhold, and J. Rubio
207 *Experience with building a commodity Intel-based ccNUMA system*

Brütting, W.
77 see Riess, W.

Burke, J. F.
439 see Davison, D. B.

Carpenter, G. D.
207 see Brock, B. C.

Castelli, V., R. E. Harper, P. Heidelberger, S. W. Hunter, K. S. Trivedi, K. Vaidyanathan, and W. P. Zeggert
311 *Proactive management of software aging*

Chiprout, E.
207 see Brock, B. C.

Chondroudis, K.
29 see Mitzi, D. B.

Corbin, J. S.
771 see Notohardjono, B. D.

- Curioni, A.**, and W. Andreoni
101 *Computer simulations for organic light-emitting diodes*
- Curioni, A.**
397 see Andreoni, W.
- Davison, D. B.**, and J. F. Burke
439 *Brute force estimation of the number of human genes using EST clustering as a measure*
- De Backer, P. L.**
207 see Brock, B. C.
- Dean, M. E.**
207 see Brock, B. C.
- Delamarche, E.**
697 see Michel, B.
- Dhaliwal, R. S.**, W. A. Enichen, S. D. Golladay, M. S. Gordon, R. A. Kendall, J. E. Lieberman, H. C. Pfeiffer, D. J. Pinckney, C. F. Robinson, J. D. Rockrohr, W. Stickel, and E. V. Tressler
615 *PREVAIL—Electron projection technology approach for next-generation lithography*
- Dimitrakopoulos, C. D.**, and D. J. Mascaró
11 *Organic thin-film transistors: A review of recent advances*
- Doyle, H.**
47 see Murray, C. B.
- Dunham, T. G.**
651 see Liebmann, L. W.
- Eastwood, M. P.**, C. Hardin, Z. Luthey-Schulten, and P. G. Wolynes
475 *Evaluating protein structure-prediction schemes using energy landscape theory*
- Elnozahy, E. N.**
207 see Brock, B. C.
- Enichen, W. A.**
615 see Dhaliwal, R. S.
- Fain, B.**, Y. Xia, and M. Levitt
525 *Determination of optimal Chebyshev-expanded hydrophobic discrimination function for globular proteins*
- Fedynyshyn, T. H.**
605 see Bates, A. K.
- Floratos, A.**, I. Rigoutsos, L. Parida, and Y. Gao
455 *DELPHI: A pattern-based method for detecting sequence similarity*
- Floratos, A.**
533 see Platt, D. E.
- Franaszek, P. A.**, P. Heidelberg, D. E. Poff, and J. T. Robinson
245 *Algorithms and data structures for compressed-memory machines*
- Franaszek, P. A.**, and J. T. Robinson
259 *On internal organization in compressed random-access memories*
- Franaszek, P. A.**
271 see Tremaine, R. B.
- Franke, H.**
287 see Abali, B.
- Franke, H.**
207 see Brock, B. C.
- Gao, Y.**
455 see Floratos, A.
- Gao, Y.**
533 see Platt, D. E.
- Gaschler, W.**
47 see Murray, C. B.
- Geissler, M.**
697 see Michel, B.
- Giampapa, M. E.**
207 see Brock, B. C.
- Glasco, D.**
207 see Brock, B. C.
- Golladay, S. D.**
615 see Dhaliwal, R. S.
- Gordon, M. S.**
615 see Dhaliwal, R. S.
- Guarnieri, C. R.**
639 see Medeiros, D. R.
- Hardin, C.**
475 see Eastwood, M. P.
- Harper, R. E.**
311 see Castelli, V.
- Heidelberg, P.**
311 see Castelli, V.
- Heidelberg, P.**
245 see Franaszek, P. A.
- Heller, T. J.**
819 see Matick, R. E.
- Herger, L. M.**
287 see Abali, B.
- Hinsberg, W. D.**, F. A. Houle, M. I. Sanchez, and G. M. Wallraff
667 *Chemical and physical aspects of the post-exposure baking process used for positive-tone chemically amplified resists*
- Holst, M. J.**
427 see Baker, N. A.
- Houle, F. A.**
667 see Hinsberg, W. D.
- Howard, W. E.**, and O. F. Prache
115 *Microdisplays based upon organic light-emitting diodes*
- Hu, E. C.**, P. A. Joubert, R. B. King, J. D. LaVoie, and J. M. Tracey
191 *Adaptive Fast Path Architecture*
- Huang, L.**, L. Massa, and J. Karle
409 *Quantum crystallography, a developing area of computational chemistry extending to macromolecules*
- Huang, W.-S.**
639 see Medeiros, D. R.
- Hunter, S. W.**
311 see Castelli, V.
- Ignatowski, M.**
819 see Matick, R. E.
- Irvin, D. R.**
789 *Embedding a secondary communication channel transparently within a cyclic redundancy check (CRC)*
- Ito, H.**
683 *Dissolution behavior of chemically amplified resist polymers for 248-, 193-, and 157-nm lithography*
- Joseph, D. J.**
229 see Nanda, A. K.
- Joubert, P. A.**
191 see Hu, E. C.
- Juncker, D.**
697 see Michel, B.

- Kagan, C. R.**
29 see Mitzi, D. B.
- Kagan, C. R.**
47 see Murray, C. B.
- Karle, J.**
409 see Huang, L.
- Kendall, R. A.**
615 see Dhaliwal, R. S.
- Khoroshun, D. V.**
367 see Morokuma, K.
- Kind, H.**
697 see Michel, B.
- King, R. B.**
191 see Hu, E. C.
- Kuczynski, J., and A. K. Sinha**
783 *Strain measurement and numerical analysis of an epoxy adhesive subjected to thermal loads*
- Kumar, S., H. J. Wolfson, and R. Nussinov**
499 *Protein flexibility and electrostatic interactions*
- Kumar, S.**
513 see Tsai, C.-J.
- Kunz, R. R.**
605 see Bates, A. K.
- Kwong, R.**
639 see Medeiros, D. R.
- Lavin, M. A.**
651 see Liebmann, L. W.
- LaVoie, J. D.**
191 see Hu, E. C.
- Leipold, W. C.**
651 see Liebmann, L. W.
- Levitt, M.**
525 see Fain, B.
- Lieberman, V.**
605 see Bates, A. K.
- Lieberman, J. E.**
615 see Dhaliwal, R. S.
- Liebmann, L. W., S. M. Mansfield, A. K. Wong, M. A. Lavin, W. C. Leipold, and T. G. Dunham**
651 *TCAD development for lithography resolution enhancement*
- Luthey-Schulten, Z.**
475 see Eastwood, M. P.
- Ma, B.**
513 see Tsai, C.-J.
- Magg, C. K.**
639 see Medeiros, D. R.
- Mahorowala, A. P.**
639 see Medeiros, D. R.
- Mansfield, S. M.**
651 see Liebmann, L. W.
- Mascaro, D. J.**
11 see Dimitrakopoulos, C. D.
- Massa, L.**
409 see Huang, L.
- Matick, R. E., T. J. Heller, and M. Ignatowski**
819 *Analytical analysis of finite cache penalty and cycles per instruction of a multiprocessor memory hierarchy using miss rates and queuing theory*
- Mazzuca, S. J.**
771 see Notohardjono, B. D.
- McCammon, J. A.**
427 see Baker, N. A.
- McIntosh, S. C.**
771 see Notohardjono, B. D.
- McMurtry, P.**
417 see Ayton, G. S. D.
- Medeiros, D. R., A. Aviram, C. R. Guarnieri, W.-S. Huang, R. Kwong, C. K. Magg, A. P. Mahorowala, W. M. Moreau, K. E. Petrillo, and M. Angelopoulos**
639 *Recent progress in electron-beam resists for advanced mask-making*
- Michael, M. M.**
229 see Nanda, A. K.
- Michel, B., A. Bernard, A. Bietsch, E. Delamarche, M. Geissler, D. Juncker, H. Kind, J.-P. Renault, H. Rothuizen, H. Schmid, P. Schmidt-Winkel, R. Stutz, and H. Wolf**
697 *Printing meets lithography: Soft approaches to high-resolution patterning*
- Mitzi, D. B., K. Chondroudis, and C. R. Kagan**
29 *Organic-inorganic electronics*
- Mordasini, T.**
397 see Andreoni, W.
- Moreau, W. M.**
639 see Medeiros, D. R.
- Morokuma, K., D. G. Musaev, T. Vreven, H. Basch, M. Torrent, and D. V. Khoroshun**
367 *Model studies of the structures, reactivities, and reaction mechanisms of metalloenzymes*
- Müller, P.**
89 see Alvarado, S. F.
- Müller, P.**
77 see Riess, W.
- Murray, C. B., Shouheng Sun, W. Gaschler, H. Doyle, T. A. Betley, and C. R. Kagan**
47 *Colloidal synthesis of nanocrystals and nanocrystal superlattices*
- Musaev, D. G.**
367 see Morokuma, K.
- Nanda, A. K., A.-T. Nguyen, M. M. Michael, and D. J. Joseph**
229 *High-throughput coherence control and hardware messaging in Everest*
- Nguyen, A.-T.**
229 see Nanda, A. K.
- Notohardjono, B. D., J. S. Corbin, S. J. Mazzuca, S. C. McIntosh, and H. Welz**
771 *Modular server frame with robust earthquake retention*
- Nussinov, R.**
499 see Kumar, S.
- Nussinov, R.**
513 see Tsai, C.-J.
- Ortega, A.**
797 see Alfonseca, M.
- Parida, L.**
455 see Floratos, A.
- Parida, L.**
533 see Platt, D. E.
- Peterson, J. L.**
207 see Brock, B. C.
- Petrillo, K. E.**
639 see Medeiros, D. R.

- Pfeiffer, H. C.**
615 see Dhaliwal, R. S.
- Pinckney, D. J.**
615 see Dhaliwal, R. S.
- Platt, D. E.,** L. Parida, Y. Gao, A. Floratos, and I. Rigoutsos
533 *QSAR in grossly underdetermined systems: Opportunities and issues*
- Poff, D. E.**
287 see Abali, B.
- Poff, D. E.**
245 see Franaszek, P. A.
- Poff, D. E.**
303 see Smith, T. B.
- Prache, O. F.**
115 see Howard, W. E.
- Rajamony, R.**
207 see Brock, B. C.
- Ravindran, R.**
207 see Brock, B. C.
- Rawson, F. L.**
207 see Brock, B. C.
- Renault, J.-P.**
697 see Michel, B.
- Riel, H.**
77 see Riess, W.
- Riess, W.,** H. Riel, T. Beierlein, W. Brütting, P. Müller, and P. F. Seidler
77 *Influence of trapped and interfacial charges in organic multilayer light-emitting devices*
- Riess, W.**
89 see Alvarado, S. F.
- Rigoutsos, I.**
455 see Floratos, A.
- Rigoutsos, I.**
533 see Platt, D. E.
- Robinson, C. F.**
615 see Dhaliwal, R. S.
- Robinson, J. T.**
245 see Franaszek, P. A.
- Robinson, J. T.**
259 see Franaszek, P. A.
- Robinson, J. T.**
271 see Tremaine, R. B.
- Rockhold, R. L.**
207 see Brock, B. C.
- Rockrohr, J. D.**
615 see Dhaliwal, R. S.
- Rossi, L.**
89 see Alvarado, S. F.
- Rothschild, M.**
605 see Bates, A. K.
- Rothuizen, H.**
697 see Michel, B.
- Rubio, J.**
207 see Brock, B. C.
- Saccone, R. A., Jr.**
287 see Abali, B.
- Sanchez, M. I.**
667 see Hinsberg, W. D.
- Schmid, H.**
697 see Michel, B.
- Schmidt-Winkel, P.**
697 see Michel, B.
- Schulz, C. O.**
287 see Abali, B.
- Schulz, C. O.**
271 see Tremaine, R. B.
- Seidler, P. F.**
89 see Alvarado, S. F.
- Seidler, P. F.**
77 see Riess, W.
- Seidler, P. F.**
3 see Shaw, J. M.
- Sept, D.**
427 see Baker, N. A.
- Sham, Y. Y.**
513 see Tsai, C.-J.
- Shaw, J. M.,** and P. F. Seidler
3 *Organic electronics: Introduction*
- Sinha, A. K.**
783 see Kuczynski, J.
- Smith, T. B.,** B. Abali, D. E. Poff, and R. B. Tremaine
303 *Memory Expansion Technology (MXT): Competitive impact*
- Smith, T. B.**
287 see Abali, B.
- Smith, T. B.**
271 see Tremaine, R. B.
- Steele, S. W.**
763 *Uninterruptible battery backup for IBM AS/400 systems*
- Stickel, W.**
615 see Dhaliwal, R. S.
- Stutz, R.**
697 see Michel, B.
- Sulsky, D.**
417 see Ayton, G. S. D.
- Sun, Shouheng**
47 see Murray, C. B.
- Switkes, M.**
605 see Bates, A. K.
- Torrent, M.**
367 see Morokuma, K.
- Tracey, J. M.**
191 see Hu, E. C.
- Tremaine, R. B.,** P. A. Franaszek, J. T. Robinson, C. O. Schulz, T. B. Smith, M. E. Wazlowski, and P. M. Bland
271 *IBM Memory Expansion Technology (MXT)*
- Tremaine, R. B.**
303 see Smith, T. B.
- Tressler, E. V.**
615 see Dhaliwal, R. S.
- Trivedi, K. S.**
311 see Castelli, V.
- Tsai, C.-J.,** B. Ma, Y. Y. Sham, S. Kumar, H. J. Wolfson, and R. Nussinov
513 *A hierarchical, building-block-based computational scheme for protein structure prediction*
- Vaidyanathan, K.**
311 see Castelli, V.
- Voth, G. A.**
417 see Ayton, G. S. D.

Vreven, T.
 367 see Morokuma, K.

Wallraff, G. M.
 667 see Hinsberg, W. D.

Wazłowski, M. E.
 271 see Tremaine, R. B.

Welz, H.
 771 see Notohardjono, B. D.

Wolf, H.
 697 see Michel, B.

Wolfson, H. J.
 499 see Kumar, S.

Wolfson, H. J.
 513 see Tsai, C.-J.

Wolynes, P. G.
 475 see Eastwood, M. P.

Wong, A. K.
 651 see Liebmann, L. W.

Xia, Y.
 525 see Fain, B.

Zeggert, W. P.
 311 see Castelli, V.

Zuliani, P.
 807 *Logical reversibility*